



TEST REPORT

ETSI EN 300 328 V2.2.2 (2019-07)

Report Number: ZKT-24121918954E-2

Date of Test: Dec. 19, 2024 to Dec. 30, 2024

Date of issue: Dec. 30, 2024

Total number of pages: 42

Test Result: PASS

Testing Laboratory: Shenzhen ZKT Technology Co., Ltd.

Address: 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name: Dong Guan Jvin Electronic Co.,LTD.

Address: Room 701, No. 381 Daxing Road, Yangwu, Dalingshan, Dongguan, Guangdong province, China

Manufacturer's name: Dong Guan Jvin Electronic Co.,LTD.

Address: Room 701, No. 381 Daxing Road, Yangwu, Dalingshan, Dongguan, Guangdong province, China

Test specification:

Standard: ETSI EN 300 328 V2.2.2 (2019-07)

Test procedure: /

Non-standard test method: N/A

This device described above has been tested by ZKT, and the test results show that the equipment under test (EUT) is in compliance with the 2014/53/EU RED Directive Art.3.2 requirements. And it is applicable only to the tested sample identified in the report.

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Product name: projector

Trademark: N/A

Model/Type reference: K6

K7, K8, K9, K10, K11, K12, K13, K15, K16

Ratings: Input: AC100-240V, 50/60Hz

**Testing procedure and testing location:****Testing Laboratory.....:** Shenzhen ZKT Technology Co., Ltd.**Address.....:** 1/F, No. 101, Building B, No. 6, Tangwei Community
Industrial Avenue, Fuhai Street, Bao'an District,
Shenzhen, China

Tested by (name + signature).....: Jim Liu

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Approved (name + signature).....: Lake Xie



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1. VERSION

Report No.	Issue Date	Description	Approved
ZKT-24121918954E-2	Dec. 30, 2024	Original	Valid

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2.TEST SUMMARY

The Product has been tested according to the following specifications:

No.	Test Parameter	Clause No	Results
Transmitter Parameters			
1	RF output power	4.3.1.2	PASS
2	Duty Cycle, Tx-sequence, Tx-gap	4.3.1.3	N/A
3	Accumulated Transmit Time, Frequency Occupation and Hopping Sequence	4.3.1.4	PASS
4	Hopping Frequency Separation	4.3.1.5	PASS
5	Medium Utilization (MU) factor	4.3.1.6	N/A
6	Adaptivity (Adaptive Frequency Hopping)	4.3.1.7	N/A
7	Occupied Channel Bandwidth	4.3.1.8	PASS
8	Transmitter unwanted emissions in the out-of-band domain	4.3.1.9	PASS
10	Transmitter unwanted emissions in the spurious domain	4.3.1.10	PASS
Receiver Parameters			
11	Receiver spurious emissions	4.3.1.11	PASS
12	Receiver Blocking	4.3.1.12	PASS
13	Geo-location Capability	4.3.1.13	N/A

Note: N/A is an abbreviation for Not Applicable and means this test item is not applicable for this device according to the technology characteristic of device.

Remark:

N/A is an abbreviation for Not Applicable and means this test item is not applicable for this device according to the technology characteristic of device.



3.MEASUREMENT UNCERTAINTY

3.1 TEST FACILITY

Shenzhen ZKT Technology Co., Ltd.
Add.: ZKT Building & 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China
FCC Test Firm Registration Number: 712850
IC Registered No.: 23583

3.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately 95 %.

No.	Item	Uncertainty
1	3m chamber Radiated spurious emission(9KHz-30MHz)	$U=4.5\text{dB}$
2	3m chamber Radiated spurious emission(30MHz-1GHz)	$U=4.8\text{dB}$
3	3m chamber Radiated spurious emission(1GHz-6GHz)	$U=4.9\text{dB}$
4	3m chamber Radiated spurious emission(6GHz-40GHz)	$U=5.0\text{dB}$
5	Conducted disturbance	$U=3.2\text{dB}$
6	RF Band Edge	$U=1.68\text{dB}$
7	RF power conducted	$U=1.86\text{dB}$
8	RF conducted Spurious Emission	$U=2.2\text{dB}$
9	RF Occupied Bandwidth	$U=1.8\text{dB}$
10	RF Power Spectral Density	$U=1.75\text{dB}$
11	humidity uncertainty	$U=5.3\%$
12	Temperature uncertainty	$U=0.59^\circ\text{C}$



4.GENERAL INFORMATION

4.1 General Description Of EUT

Model(s):	projector
Model Description:	K6 K7, K8, K9, K10, K11, K12, K13, K15, K16
Hardware Version:	H1.0
Software Version:	S1.0
Operation Frequency:	Bluetooth: 2402-2480MHz
Max. RF output power:	Bluetooth: 1.31dBm
Type of Modulation:	Bluetooth: GFSK, Pi/4DQPSK,8-DPSK PCB Antenna, Maximum Gain is 0dBi
Antenna Type:	Note: the antenna gain is provided by the customer, and the final test result has nothing to do with us.
EUT Ratings:	Input: AC100-240V, 50/60Hz

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Data Cable	Power Cord
1.	---	---	---	---	---	--

Notes:

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

4.4 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting (GFSK/Pi/4DQPSK/8-DPSK)	2402MHz	2441MHz	2480MHz
Receiving (GFSK/Pi/4DQPSK/8-DPSK)	2402MHz	2441MHz	2480MHz



4.5 Test Environment

1. Extreme Test Conditions:

For tests at extreme temperatures, measurements shall be made over the extremes of the operating temperature range as declared by the manufacturer.

For tests at extreme voltages, measurements shall be made over the extremes of the power source voltage range as declared by the manufacturer.

Test Conditions	LTLV	HTHV	LTLV	HTLV
Temperature (°C)	-10	-10	40	40
Test Voltage (DC)	3.33	4.07	3.33	4.07



4.7 Equipments List For All Test Items

Radiation Emissions & Radiation Spurious Emissions Test

Item	Equipment	Manufacturer	Type No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Spectrum Analyzer (9kHz-26.5GHz)	KEYSIGHT	N9020A	MY55370835	A.17.05	Sep. 29, 2024	Sep. 28, 2025
2	Spectrum Analyzer (10kHz-39.9GHz)	R&S	FSV40-N	100363	1.71 SP2	Sep. 30, 2024	Sep. 29, 2025
3	EMI Test Receiver (9kHz-7GHz)	R&S	ESCI7	100969	4.32	Sep. 29, 2024	Sep. 28, 2025
4	Bilog Antenna (30MHz-1500MHz)	Schwarzbeck	VULB9168	00877	N/A	Sep. 30, 2024	Sep. 29, 2025
5	Horn Antenna (1GHz-18GHz)	Agilent	AH-118	071145	N/A	Sep. 30, 2024	Sep. 29, 2025
6	Horn Antenna (15GHz-40GHz)	A.H.System	SAS-574	588	N/A	Sep. 30, 2024	Sep. 29, 2025
7	Loop Antenna	TESEQ	HLA6121	58357	N/A	Oct. 11, 2024	Oct. 10, 2025
8	Amplifier (30-1000MHz)	EM Electronics	EM330 Amplifier	60747	N/A	Sep. 29, 2024	Sep. 28, 2025
9	Amplifier (1GHz-26.5GHz)	HuiPu	8449B	3008A00315	N/A	Sep. 29, 2024	Sep. 28, 2025
10	Amplifier (500MHz-40GHz)	QuanJuDa	DLE-161	097	N/A	Sep. 30, 2024	Sep. 29, 2025
11	Test Cable	N/A	R-01	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
12	Test Cable	N/A	R-02	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
13	Test Cable	N/A	R-03	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
14	D.C. Power Supply	LongWei	TPR-6405D	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
15	EMC Software	Frad	EZ-EMC	Ver.EMC-CO N 3A1.1	N/A	\	\
16	Turntable	MF	MF-7802BS	N/A	N/A	\	\
17	Antenna tower	MF	MF-7802BS	N/A	N/A	\	\

RF Conducted Test

Item	Equipment	Manufacturer	Type No.	Serial No.	Firmware Version	Last calibration	Calibrated until
1	Spectrum Analyzer (9kHz-26.5GHz)	KEYSIGHT	N9020A	MY55370835	A.17.05	Sep. 29, 2024	Sep. 28, 2025
2	Spectrum Analyzer (10kHz-39.9GHz)	R&S	FSV40-N	100363	1.71 SP2	Sep. 30, 2024	Sep. 29, 2025
3	Test Cable	N/A	RF-01	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
4	Test Cable	N/A	RF-02	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
5	Test Cable	N/A	RF-03	N/A	N/A	Sep. 30, 2024	Sep. 29, 2025
6	ESG Signal Generator	Agilent	E4421B	N/A	B.03.84	Sep. 29, 2024	Sep. 28, 2025
7	Signal Generator	Agilent	N5182A	N/A	A.01.87	Sep. 29, 2024	Sep. 28, 2025
8	Magnetic Field Probe Tester	Narda	ELT-400	0-0344/M-17 52	N/A	Nov. 16, 2023	Nov. 15, 2024
9	Van der Hoofden measuring head	Schwarzbeck Mess-elektron	VDHH 9502	9502-039	N/A	Sep. 30, 2024	Sep. 29, 2025

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		ik					
10	Wideband Radio Communication Test	R&S	CMW500	106504	V 3.7.22	Sep. 30, 2024	Sep. 29, 2025
11	MWRF Power Meter Test system	MW	MW100-RF CB	N/A	N/A	Sep. 29, 2024	Sep. 28, 2025
12	D.C. Power Supply	LongWei	TPR-6405 D	N/A	N/A	Sep. 29, 2024	Sep. 28, 2025
13	RF Software	MW	MTS8310	V2.0.0.0	N/A	\	\



5.INFORMATION AS REQUIRED

ETSI EN 300 328 Annex E

a) The type of modulation used by the equipment:

- FHSS
- other forms of modulation

b) In case of FHSS modulation:

- In case of non-Adaptive Frequency Hopping equipment:

The number of Hopping Frequencies: _

- In case of Adaptive Frequency Hopping Equipment:

The maximum number of Hopping Frequencies: 79

The minimum number of Hopping Frequencies: 79

- The (average) Dwell Time: 307.20maximum

c) Adaptive / non-adaptive equipment:

- non-adaptive Equipment
- adaptive Equipment without the possibility to switch to a non-adaptive mode
- adaptive Equipment which can also operate in a non-adaptive mode

d) In case of adaptive equipment:

The Channel Occupancy Time implemented by the equipment: 1228.8ms

- The equipment has implemented an LBT based DAA mechanism

- In case of equipment using modulation different from FHSS:

- The equipment is Frame Based equipment
- The equipment is Load Based equipment
- The equipment can switch dynamically between Frame Based and Load Based equipment

The CCA time implemented by the equipment: μ s

- The equipment has implemented an non-LBT based DAA mechanism

- The equipment can operate in more than one adaptive mode

e) In case of non-adaptive Equipment:

The maximum RF Output Power (e.i.r.p.): _

The maximum (corresponding) Duty Cycle:

Equipment with dynamic behaviour, that behaviour is described here. (e.g. the different combinations of duty cycle and corresponding power levels to be declared):
.....

f) The worst case operational mode for each of the following tests:

- RF Output Power: GFSK
- Power Spectral Density:
- Duty cycle, Tx-Sequence, Tx-gap:
- Accumulated Transmit time, Frequency Occupation & Hopping Sequence (only for FHSS equipment): $\pi/4$ DPSK
- Hopping Frequency Separation (only for FHSS equipment): GFSK
- Medium Utilization:
- Adaptivity:
- Nominal Channel Bandwidth: GFSK
- Transmitter unwanted emissions in the OOB domain: GFSK
- Transmitter unwanted emissions in the spurious domain: GFSK
- Receiver spurious emissions : GFSK
- Receiver blocking : GFSK

g) The different transmit operating modes (tick all that apply):

- Operating mode 1: Single Antenna Equipment
 - Equipment with only one antenna
 - Equipment with two diversity antennas but only one antenna active at any moment in time
 - Smart Antenna Systems with two or more antennas, but operating in a (legacy) mode where only One antenna is used (e.g. IEEE 802.11™ [i.3] legacy mode in smart antenna systems)
- Operating mode 2: Smart Antenna Systems - Multiple Antennas without beam forming
 - Single spatial stream / Standard throughput / (e.g. IEEE 802.11™ [i.3] legacy mode)
 - High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 1
 - High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 2



NOTE 1: Add more lines if more channel bandwidths are supported.

- Operating mode 3: Smart Antenna Systems - Multiple Antennas with beam forming
 - Single spatial stream / Standard throughput (e.g. IEEE 802.11™ [i.3] legacy mode)
 - High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 1
 - High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 2

NOTE 2: Add more lines if more channel bandwidths are supported.

h) In case of Smart Antenna Systems:

The number of Receive chains:

The number of Transmit chains:

- symmetrical power distribution
- asymmetrical power distribution

In case of beam forming, the maximum (additional) beam forming gain:

NOTE: The additional beam forming gain does not include the basic gain of a single antenna.

i) Operating Frequency Range(s) of the equipment:

Operating Frequency Range 1: Refer to section 4.1

Operating Frequency Range 2: _____

NOTE: Add more lines if more Frequency Ranges are supported.

j) Nominal Channel Bandwidth(s):

Nominal Channel Bandwidth 1: 1.203MHz Max.

NOTE: Add more lines if more channel bandwidths are supported.

k) Type of Equipment (stand-alone, combined, plug-in radio device, etc.):

- Stand-alone
- Combined Equipment (Equipment where the radio part is fully integrated within another type of equipment)
- Plug-in radio device (Equipment intended for a variety of host systems)
- Other

l) The normal and the extreme operating conditions that apply to the equipment:

Refer to section 4.6

m) The intended combination(s) of the radio equipment power settings and one or more antenna assemblies and their corresponding e.i.r.p. levels:

Antenna Type:

- PCB antenna (information to be provided in case of conducted measurements)

Antenna Gain: Refer to section 4.1

If applicable, additional beamforming gain (excluding basic antenna gain):

- Temporary RF connector provided
- No temporary RF connector provided

- Dedicated Antennas (equipment with antenna connector)

- Single power level with corresponding antenna(s)

- Multiple power settings and corresponding antenna(s)

Number of different Power Levels:

Power Level 1:

Power Level 2:

Power Level 3:

NOTE 1: Add more lines in case the equipment has more power levels.

NOTE 2: These power levels are conducted power levels (at antenna connector).

For each of the Power Levels, provide the intended antenna assemblies, their corresponding gains (G) and the resulting e.i.r.p. levels also taking into account the beamforming gain (Y) if applicable

Power Level 1:

Number of antenna assemblies provided for this power level:

Assembly #	Gain (dBi)	e.i.r.p.(dBm)	Part number or model name
1			
2			
3			
4			

NOTE 3: Add more rows in case more antenna assemblies are supported for this power level.

Power Level 2:

Number of antenna assemblies provided for this power level:



Assembly #	Gain (dBi)	e.i.r.p.(dBm)	Part number or model name
1			
2			
3			
4			

NOTE 4: Add more rows in case more antenna assemblies are supported for this power level.

Power Level 3:

Number of antenna assemblies provided for this power level:

Assembly #	Gain (dBi)	e.i.r.p.(dBm)	Part number or model name
1			
2			
3			
4			

NOTE 5: Add more rows in case more antenna assemblies are supported for this power level.

n) The nominal voltages of the stand-alone radio equipment or the nominal voltages of the combined (host) equipment or test jig in case of plug-in devices:

Refer to section 8.

o) Describe the test modes available which can facilitate testing:

.....
p) The equipment type (e.g. Bluetooth®, IEEE 802.11™ [i.3], IEEE 802.15.4™ [i.4], proprietary, etc.):.....

q) If applicable, the statistical analysis referred to in clause 5.4.1 q)
(to be provided as separate attachment)

r) If applicable, the statistical analysis referred to in clause 5.4.1 r)
(to be provided as separate attachment)

s) Geo-location capability supported by the equipment:

Yes

The geographical location determined by the equipment as defined in clause 4.3.1.13.2 or clause 4.3.2.12.2 is not accessible to the user

No

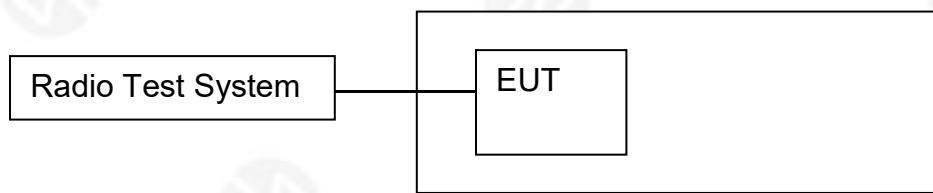
t) Describe the minimum performance criteria that apply to the equipment (see clause 4.3.1.12.3 or clause 4.3.2.11.3):

.....



6. RF OUTPUT POWER

6.1 Block Diagram Of Test Setup



6.2 Limit

For adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be 20 dBm.

The maximum RF output power for non-adaptive equipment shall be declared by the supplier and shall not exceed 20 dBm. See clause 5.3.1 m). For non-adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be equal to or less than the value declared by the supplier.

This limit shall apply for any combination of power level and intended antenna assembly.

Limit
20dBm

6.3 Test procedure

Step 1:

- Use a fast power sensor suitable for 2.4 GHz and capable of minimum 1 MS/s.
- Use the following settings:
 - Sample speed 1 MS/s or faster.
 - The samples shall represent the RMS power of the signal.
 - Measurement duration: For non-adaptive equipment: equal to the observation period defined in clause 4.3.1.3.2 or clause 4.3.2.4.2. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.
- NOTE 1: For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.

Step 2:

- For conducted measurements on devices with one transmit chain:
 - Connect the power sensor to the transmit port, sample the transmit signal and store the raw data. Use these stored samples in all following steps.
- For conducted measurements on devices with multiple transmit chains:
 - Connect one power sensor to each transmit port for a synchronous measurement on all transmit ports.
 - Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between the samples of all sensors is less than 500 ns.
 - For each individual sampling point (time domain), sum the coincident power samples of all ports and store them. Use these summed samples in all following steps.

Step 3:

- Find the start and stop times of each burst in the stored measurement samples.
- The start and stop times are defined as the points where the power is at least 30 dB below the highest value of the stored samples in step 2.
- NOTE 2: In case of insufficient dynamic range, the value of 30 dB may need to be reduced appropriately.



Step 4:

- Between the start and stop times of each individual burst calculate the RMS power over the burst using the formula below. Save these Pburst values, as well as the start and stop times for each burst.

$$P_{burst} = \frac{1}{k} \sum_{n=1}^k P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

Step 5:

- The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.

Step 6:

- Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.
- If applicable, add the additional beamforming gain "Y" in dB.
 - If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G + Y) shall be used.
- The RF Output Power (P) shall be calculated using the formula below:

$$P = A + G + Y$$

- This value, which shall comply with the limit given in clause 4.3.1.2.3 or clause 4.3.2.2.3, shall be recorded in the test report.

6.4 Test Result

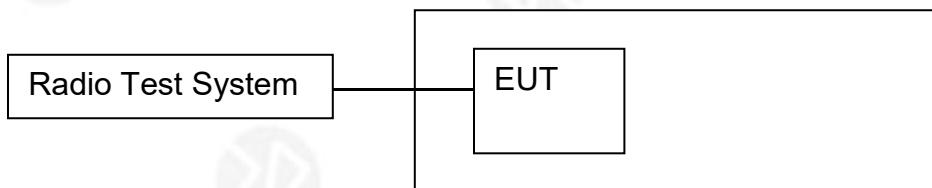
Modulation	Test conditions (Temperature)	EIRP (dBm)
		Hopping mode
GFSK	Normal	1.31
	Lower	1.29
	Upper	1.28
Pi/4DQPSK	Normal	0.56
	Lower	0.55
	Upper	0.53
8-DPSK	Normal	1.15
	Lower	1.14
	Upper	1.12
Limit		≤100mW (20dBm)

Remark: P = A + G + Y, G=-0dBi, x=100%



7. ACCUMULATED TRANSMIT TIME, MINIMUM FREQUENCY OCCUPATION AND HOPPING SEQUENCE

7.1 Block Diagram Of Test Setup



7.2 Limit

Adaptive Frequency Hopping equipment shall be capable of operating over a minimum of 70 % of the band specified in clause 1.

The Accumulated Transmit Time on any hopping frequency shall not be greater than 400 ms within any observation period of 400 ms multiplied by the minimum number of hopping frequencies (N) that have to be used. In order for the equipment to comply with the Frequency Occupation requirement, it shall meet either of the following two options:

Option 1: Each hopping frequency of the hopping sequence shall be occupied at least once within a period not exceeding four times the product of the dwell time and the number of hopping frequencies in use.

Option 2: The occupation probability for each frequency shall be between $((1 / U) \times 25\%)$ and 77 % where U is the number of hopping frequencies in use.

The hopping sequence(s) shall contain at least N hopping frequencies at all times, where N is 15 or 15 divided by the minimum Hopping Frequency Separation in MHz, whichever is the greater.

7.3 Test procedure

Step 1:

- The output of the transmitter shall be connected to a spectrum analyzer or equivalent.
- The analyzer shall be set as follows:
 - Centre Frequency: Equal to the hopping frequency being investigated
 - Frequency Span: 0 Hz
 - RBW: $\sim 50\%$ of the Occupied Channel Bandwidth
 - VBW: \geq RBW
 - Detector Mode: RMS
 - Sweep time: Equal to the applicable observation period (see clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2)
 - Number of sweep points: 30 000
 - Trace mode: Clear / Write
 - Trigger: Free Run

Step 2:

- Save the trace data to a file for further analysis by a computing device using an appropriate software application or program.

Step 3:



- Identify the data points related to the frequency being investigated by applying a threshold.

The data points resulting from transmissions on the hopping frequency being investigated are assumed to have much higher levels compared to data points resulting from transmissions on adjacent hopping frequencies. If a clear determination between these transmissions is not possible, the RBW in step 1 shall be further reduced. In addition, a channel filter may be used.

- Count the number of data points identified as resulting from transmissions on the frequency being investigated and multiply this number by the time difference between two consecutive data points.

Step 4:

- The result in step 3 is the Accumulated Transmit Time which shall comply with the limit provided in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 and which shall be recorded in the test report.

Step 5:

NOTE 1: This step is only applicable for equipment implementing Option 1 in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 for complying with the Frequency Occupation requirement and the manufacturer decides to demonstrate compliance with this requirement via measurement.

- Make the following changes on the analyser and repeat step 2 and step 3.

Sweep time: $4 \times \text{Dwell Time} \times \text{Actual number of hopping frequencies in use}$

The hopping frequencies occupied by the equipment without having transmissions during the dwell time (blacklisted frequencies) should be taken into account in the actual number of hopping frequencies in use. If this number cannot be determined (number of blacklisted frequencies unknown) it shall be assumed that the equipment uses the maximum possible number of hopping frequencies.

- The result shall be compared to the limit for the Frequency Occupation defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2. The result of this comparison shall be recorded in the test report.

Step 6:

- Make the following changes on the analyzer:

- Start Frequency: 2 400 MHz
- Stop Frequency: 2 483,5 MHz
- RBW: ~ 50 % of the Occupied Channel Bandwidth (single hopping frequency)
- VBW: \geq RBW
- Detector Mode: RMS
- Sweep time: 1 s
- Trace Mode: Max Hold
- Trigger: Free Run

NOTE 2: The above sweep time setting may result in long measuring times. To avoid such long measuring times, an FFT analyser could be used.

- Wait for the trace to stabilize. Identify the number of hopping frequencies used by the hopping sequence.
- The result shall be compared to the limit (value N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2. This value shall be recorded in the test report.



For equipment with blacklisted frequencies, it might not be possible to verify the number of hopping frequencies in use. However they shall comply with the requirement for Accumulated Transmit Time and Frequency Occupation assuming the minimum number of hopping frequencies (N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 is used.

Step 7:

- For adaptive equipment, using the lowest and highest -20 dB points from the total spectrum envelope obtained in step 6, it shall be verified whether the equipment uses 70 % of the band specified in clause 1. The result shall be recorded in the test report.

7.4 Test Result

Hopping channel

Modulation	Number of hopping channel	Limit	Result
GFSK	79	>15	PASS
Pi/4DQPSK	79	>15	PASS
8-DPSK	79	>15	PASS

Dwell time

Mode	Channel	Pulse time (ms)	Dwell time (ms)	Limit	Result
DH1	Low	0.374	118.932	<400ms	PASS
	Mid	0.374	118.932		
	High	0.374	118.932		
DH3	Low	2.884	256.676	<400ms	PASS
	Mid	2.884	256.676		
	High	2.884	256.676		
DH5	Low	6.664	346.528	<400ms	PASS
	Mid	6.664	346.528		
	High	6.664	346.528		

Note: DH1=1600/(79*(DH))*79*0.4* Pulse time .(DH1=2, DH3=4, DH5=6)

Mini Frequency Occupation Time

Mode	Channel	Dwell time(ms)	Mini frequency occupation Time(ms)	Result
DH1	Low/Mid/High	118.932	475.728	PASS
DH3	Low/Mid/High	256.676	1026.704	
DH5	Low/Mid/High	346.528	1386.112	

Remark: Mini frequency occupation Time(ms)=4*Dwell time(ms)



Operating hopping Bandwidth:

Mode	Bandwidth (MHz)	Limit(MHz)	Result
GFSK	78.45	58.45	PASS

Hopping sequence

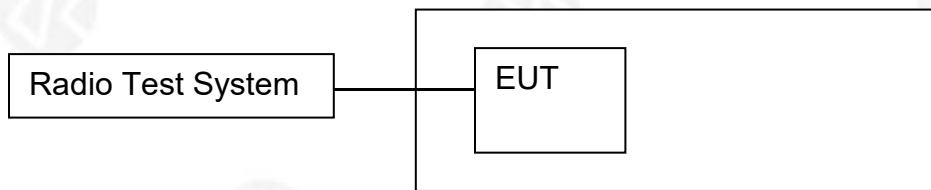
Mode	Hopping Sequence(%)	Limit	Result
GFSK	95.20%	>70%	PASS

Note: 1. For adaptive systems, using the lowest and highest -20 dB points from the total spectrum envelope, it shall be verified whether the system uses 70 % of the band specified.
2. Hopping Sequence(%) = $(20\text{dB BW}/83.5) \times 100$



8.HOPPING FREQUENCY SEPARATION

8.1 Block Diagram Of Test Setup



8.2 Limit

For Non-adaptive frequency hopping systems

The minimum Hopping Frequency Separation shall be equal to Occupied Channel Bandwidth (see clause 5.3.1.5.3) of a single hop, with a minimum separation of 100 kHz.

For Adaptive frequency hopping systems

The minimum Hopping Frequency Separation shall be 100 kHz.

8.3 Test procedure

The Hopping Frequency Separation as defined in clause 4.3.1.5 shall be measured and recorded using any of the following options. The selected option shall be stated in the test report.

Option 1

Step 1:

- The output of the transmitter shall be connected to a spectrum analyser or equivalent.
- The analyser shall be set as follows:
 - Centre Frequency: Centre of the two adjacent hopping frequencies
 - Frequency Span: Sufficient to see the complete power envelope of both hopping frequencies
 - RBW: 1 % of the span
 - VBW: $3 \times$ RBW
 - Detector Mode: RMS
 - Trace Mode: Max Hold
 - Sweep time: 1 s

Step 2:

- Wait for the trace to stabilize.
- Use the marker function of the analyser to define the frequencies corresponding to the lower -20 dBr point and the upper -20 dBr point for both hopping frequencies F1 and F2. This will result in F_{1L} and F_{1H} for hopping frequency F1 and in F_{2L} and F_{2H} for hopping frequency F2. These values shall be recorded in the report.

Step 3:

- Calculate the centre frequencies F_{1c} and F_{2c} for both hopping frequencies using the formulas below.

These values shall be recorded in the report.

$$F_{1c} = \frac{F_{1L} + F_{1H}}{2} \quad F_{2c} = \frac{F_{2L} + F_{2H}}{2}$$

- Calculate the -20 dBr channel bandwidth (BW_{CHAN}) using the formula below. This value shall be recorded in the report.



$$BW_{CHAN} = F1_H - F1_L$$

- Calculate the Hopping Frequency Separation (FHS) using the formula below. This value shall be recorded in the report.

$$F_{HS} = F2_c - F1_c$$

- Compare the measured Hopping Frequency Separation with the limit defined in clause 4.3.1.5.3. In addition, for non-Adaptive Frequency Hopping equipment, the Hopping Frequency Separation shall be equal to or greater than Occupied Channel Bandwidth as defined in clause 4.3.1.8 or:

$$F_{HS} \geq \text{Occupied Channel Bandwidth}$$

- See figure 4:

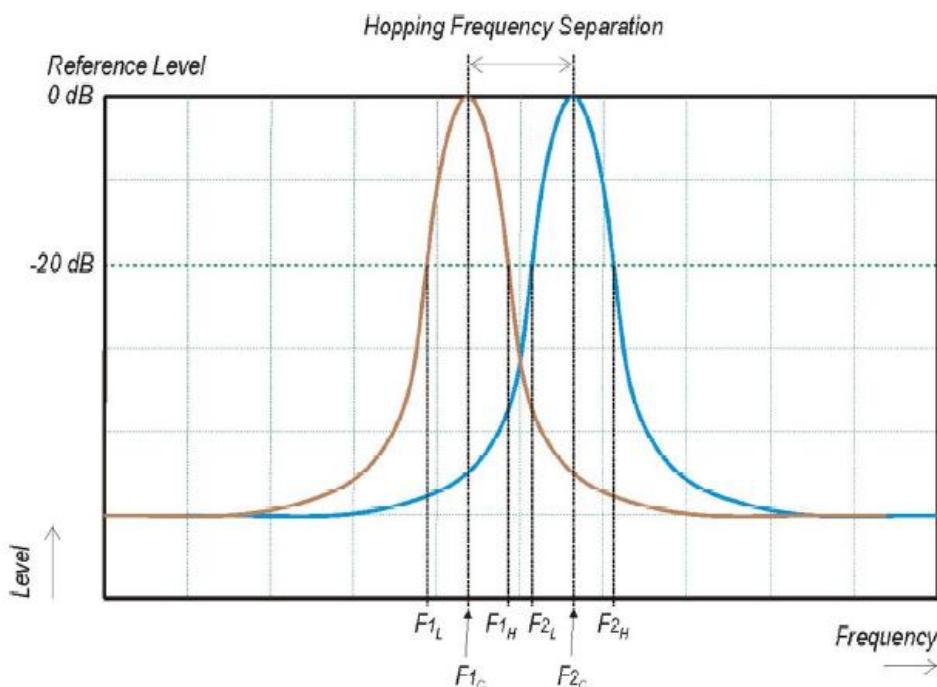


Figure 4: Hopping Frequency Separation

For adaptive equipment, in case of overlapping channels which will prevent the definition of the -20 dBr reference points $F1_H$ and $F2_L$, a higher reference level (e.g. -10 dBr or -6 dBr) may be chosen to define the reference points $F1_L$; $F1_H$; $F2_L$ and $F2_H$.

Alternatively, special test software may be used to:

- force the UUT to hop or transmit on a single Hopping Frequency by which the -20 dBr reference points can be measured separately for the two adjacent Hopping Frequencies; and/or
- force the UUT to operate without modulation by which the centre frequencies $F1_C$ and $F2_C$ can be measured directly.

The method used to measure the Hopping Frequency Separation shall be documented in the test report.



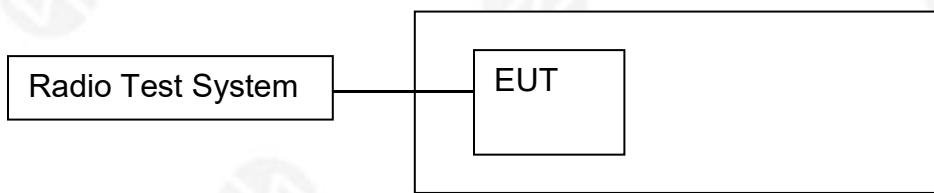
8.4 Test Result

Mode		Measurement (MHz)	Limit (MHz)	Result
GFSK	DH1	1.02	0.1	PASS
	DH3	1.01	0.1	
	DH5	0.89	0.1	



9.OCCUPIED CHANNEL BANDWIDTH

9.1 Block Diagram Of Test Setup



9.2 Limit

The Occupied Channel Bandwidth shall fall completely within the band given in 2.4GHz to 2.4835GHz. In addition, for non-adaptive systems using wide band modulations other than FHSS and with e.i.r.p greater than 10 dBm, the occupied channel bandwidth shall be less than 20 MHz.

9.3 Test procedure

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

- Centre Frequency: The centre frequency of the channel under test
- Resolution BW: ~ 1 % of the span without going below 1 %
- Video BW: 3 × RBW
- Frequency Span: 2 × Nominal Channel Bandwidth
- Detector Mode: RMS
- Trace Mode: Max Hold
- Sweep time: 1 s

Step 2:

Wait for the trace to stabilize.

Find the peak value of the trace and place the analyser marker on this peak.

Step 3:

Use the 99 % bandwidth function of the spectrum analyser to measure the Occupied Channel Bandwidth of the UUT.

This value shall be recorded.

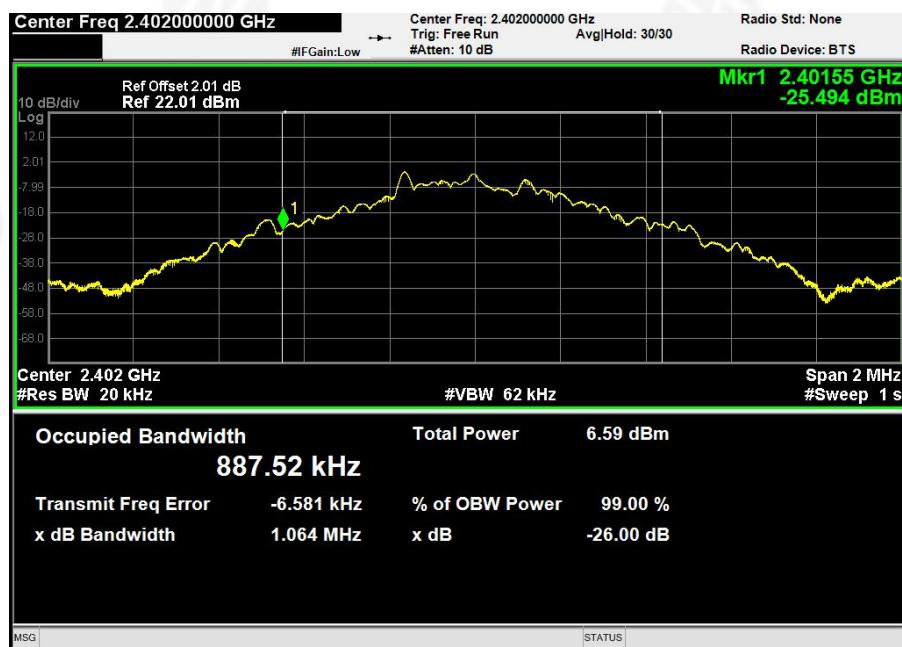
NOTE: Make sure that the power envelope is sufficiently above the noise floor of the analyser to avoid the noise signals left and right from the power envelope being taken into account by this measurement.



9.4 Test Result

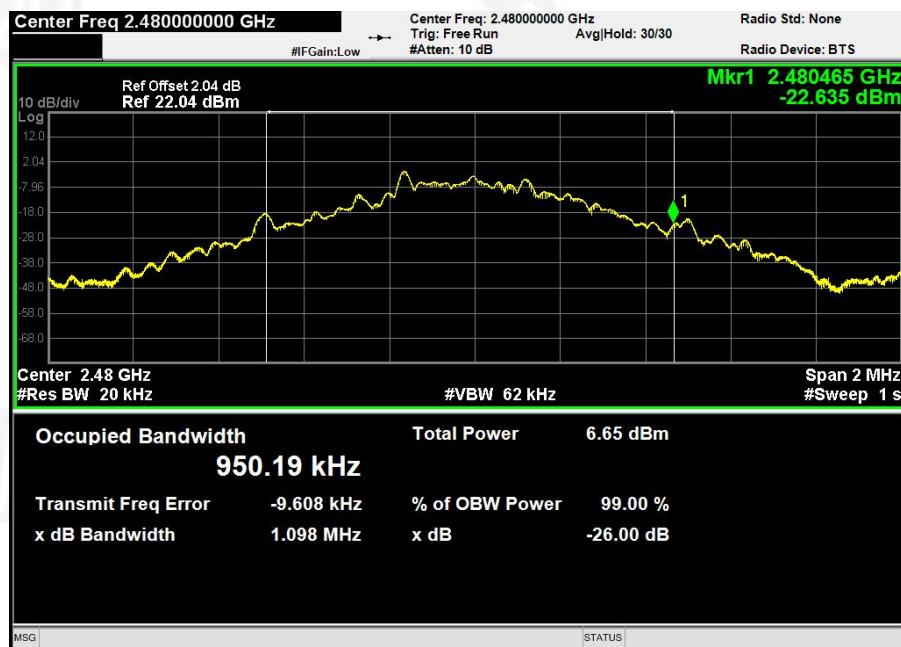
Modulation	Frequency (MHz)	Frequency Range (MHz)		Occupied Channel (MHz)
GFSK DH1	Low	2401.55	/	0.888
	High	/	2480.465	0.950
π4DQPSK(2M) 2-DH1	Low	2401.403	/	1.174
	High	/	2480.575	1.1895
8-DPSK(3M) 3-DH1	Low	2401.545	/	0.902
	High	/	2480.471	0.950

Test Plots
GFSK DH1
Low Channel

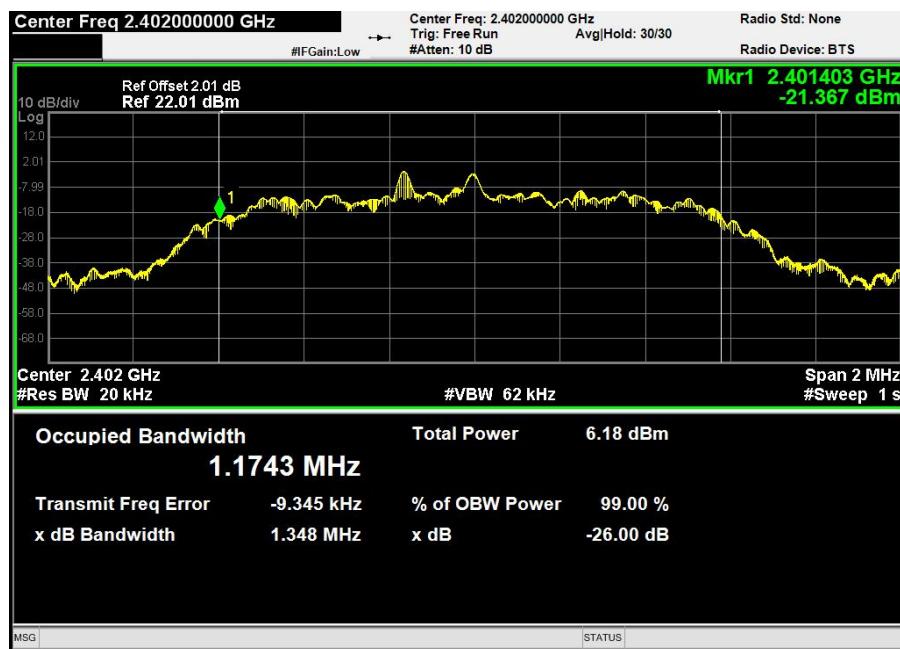




High Channel

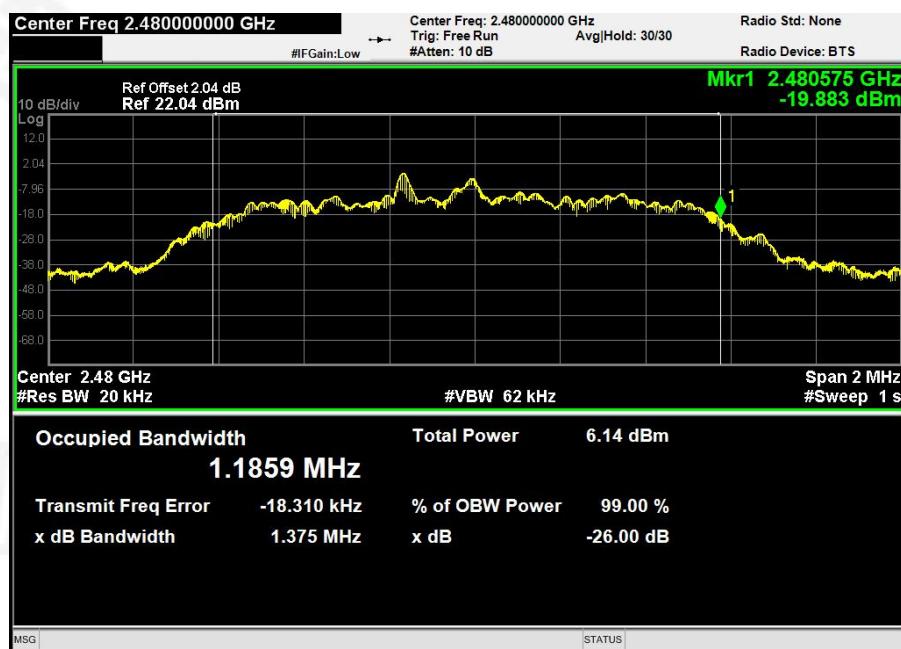


Π/4-DQPSK 2-DH-1 Low Channel





High Channel



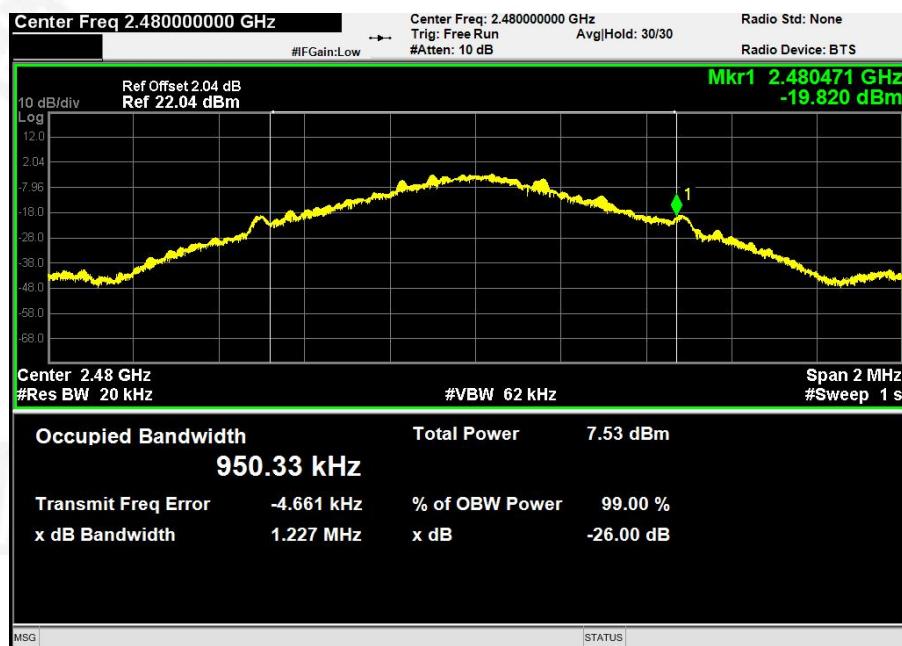
8-DPSK 3-DH-1

Low Channel





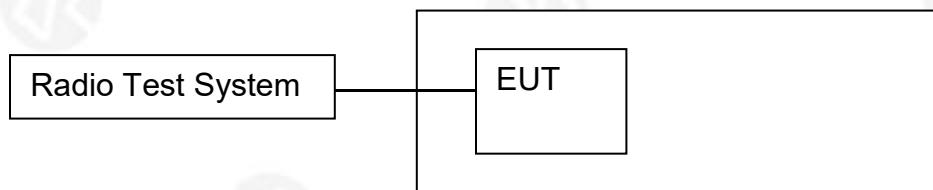
High Channel





10. TRANSMITTER UNWANTED EMISSIONS IN THE OUT-OF-BAND DOMAIN

10.1 Block Diagram Of Test Setup



10.2 Limit

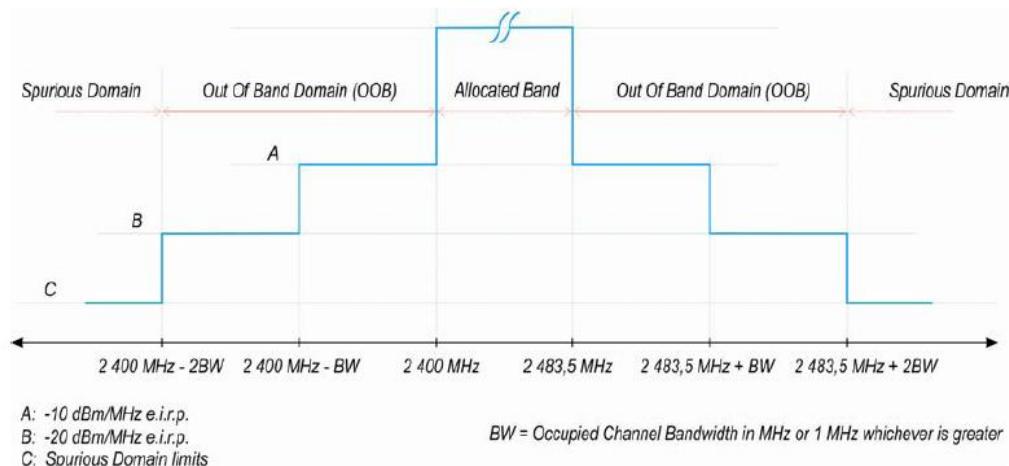


Figure 3: Transmit mask

10.3 Test procedure

The applicable mask is defined by the measurement results from the tests performed under clause 5.3.8 (Occupied Channel Bandwidth).

The test procedure is further as described under clause 5.3.9.2.1.

The Out-of-band emissions within the different horizontal segments of the mask provided in figures 1 and 3 shall be measured using the steps below. This method assumes the spectrum analyser is equipped with the Time Domain Power option.

Step 1:

- Connect the UUT to the spectrum analyser and use the following settings:
 - Centre Frequency: 2 484 MHz
 - Span: 0 Hz
 - Resolution BW: 1 MHz
 - Filter mode: Channel filter
 - Video BW: 3 MHz
 - Detector Mode: RMS
 - Trace Mode: Max Hold
 - Sweep Mode: Continuous
 - Sweep Points: Sweep Time [s] / (1 μ s) or 5 000 whichever is greater



- Trigger Mode: Video trigger

NOTE 1: In case video triggering is not possible, an external trigger source may be used.

- Sweep Time: > 120 % of the duration of the longest burst detected during the measurement of the RF Output Power

Step 2 (segment 2 483,5 MHz to 2 483,5 MHz + BW):

- Adjust the trigger level to select the transmissions with the highest power level.
- For frequency hopping equipment operating in a normal hopping mode, the different hops will result in signal bursts with different power levels. In this case the burst with the highest power level shall be selected.
- Set a window (start and stop lines) to match with the start and end of the burst and in which the RMS power shall be measured using the Time Domain Power function.
- Select RMS power to be measured within the selected window and note the result which is the RMS power within this 1 MHz segment (2 483,5 MHz to 2 484,5 MHz). Compare this value with the applicable limit provided by the mask.
- Increase the centre frequency in steps of 1 MHz and repeat this measurement for every 1 MHz segment within the range 2 483,5 MHz to 2 483,5 MHz + BW. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 3 (segment 2 483,5 MHz + BW to 2 483,5 MHz + 2BW):

- Change the centre frequency of the analyser to 2 484 MHz + BW and perform the measurement for the first 1 MHz segment within range 2 483,5 MHz + BW to 2 483,5 MHz + 2BW. Increase the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + 2 BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 4 (segment 2 400 MHz - BW to 2 400 MHz):

- Change the centre frequency of the analyser to 2 399,5 MHz and perform the measurement for the first 1 MHz segment within range 2 400 MHz - BW to 2 400 MHz. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 5 (segment 2 400 MHz - 2BW to 2 400 MHz - BW):

- Change the centre frequency of the analyser to 2 399,5 MHz - BW and perform the measurement for the first 1 MHz segment within range 2 400 MHz - 2BW to 2 400 MHz - BW. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 6:

- In case of conducted measurements on equipment with a single transmit chain, the declared antenna assembly gain "G" in dBi shall be added to the results for each of the 1 MHz segments and compared with the limits



provided by the mask given in figure 1 or figure 3. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

- In case of conducted measurements on smart antenna systems (equipment with multiple transmit chains), the measurements need to be repeated for each of the active transmit chains. The declared antenna assembly gain "G" in dBi for a single antenna shall be added to these results. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered. Comparison with the applicable limits shall be done using any of the options given below:

- Option 1: the results for each of the transmit chains for the corresponding 1 MHz segments shall be added. The additional beamforming gain "Y" in dB shall be added as well and the resulting values compared with the limits provided by the mask given in figure 1 or figure 3.

- Option 2: the limits provided by the mask given in figure 1 or figure 3 shall be reduced by

$10 \times \log_{10}(Ach)$ and the additional beamforming gain "Y" in dB. The results for each of the transmit chains shall be individually compared with these reduced limits.

NOTE 2: Ach refers to the number of active transmit chains.

It shall be recorded whether the equipment complies with the mask provided in figure 1 or figure 3.

10.4 Test Result

Condition: Normal

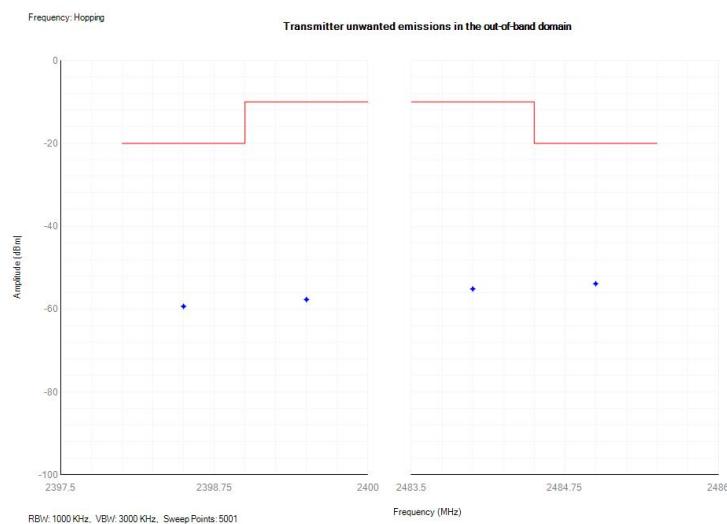
Test Condition			Lower Band Edge		Higher Band Edge	
Test Mode	Temp	Voltage	Segment A (dBm/MHz)	Segment B (dBm/MHz)	Segment A (dBm/MHz)	Segment B (dBm/MHz)
GFSK	Normal	Normal	-53.51	-42.44	-51.93	-54.12
Limit			-10	-20	-10	-20
Conclusion			PASS			

Remark: All modulations of EUT have been tested, but only show the test data of the worst case in this report.



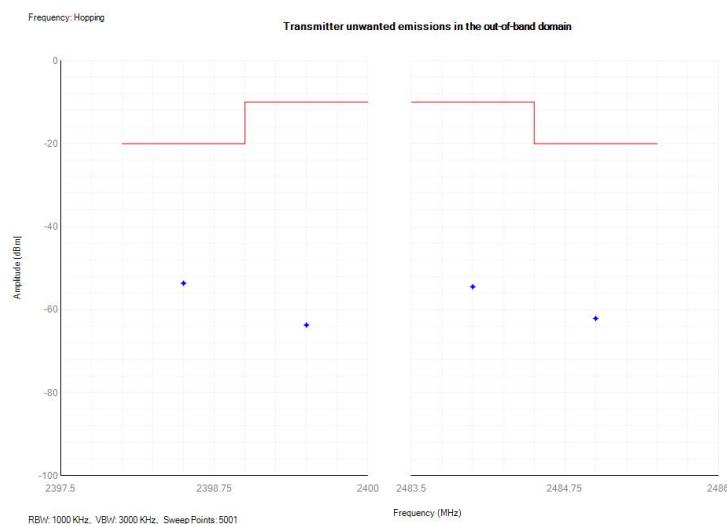
CH Low (Normal Temp)

Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit
2402	Antenna 1	2399.5	-57.7	-10
2402	Antenna 1	2398.5	-59.35	-20



CH High (Normal Temp)

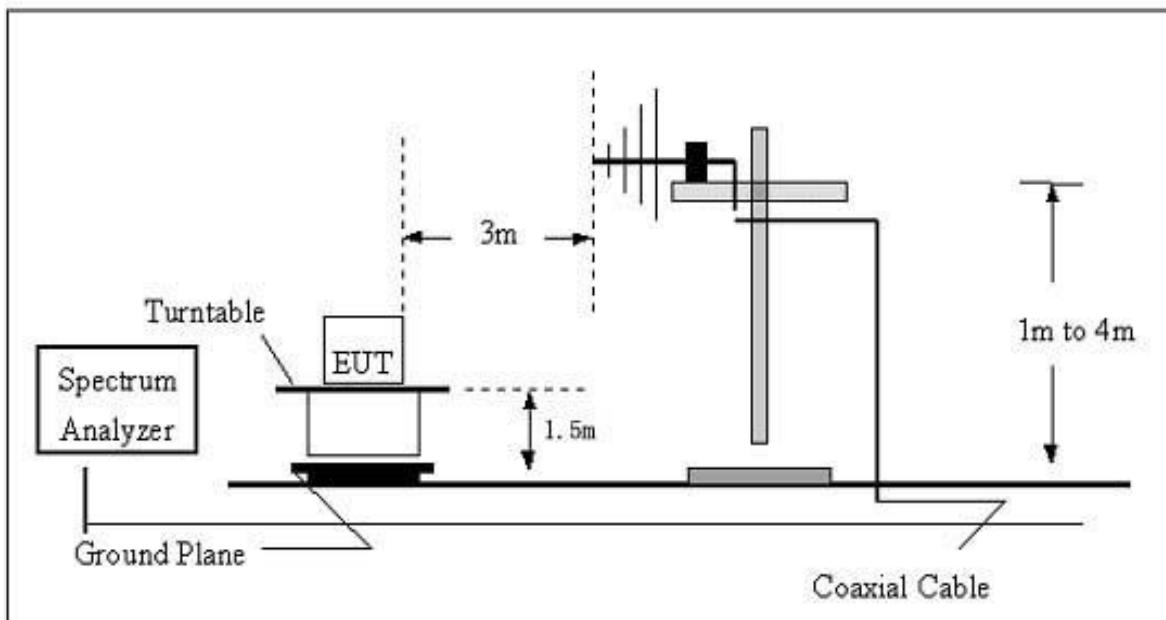
Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit
2480	Antenna 1	2484	-55.14	-10
2480	Antenna 1	2485	-53.88	-20



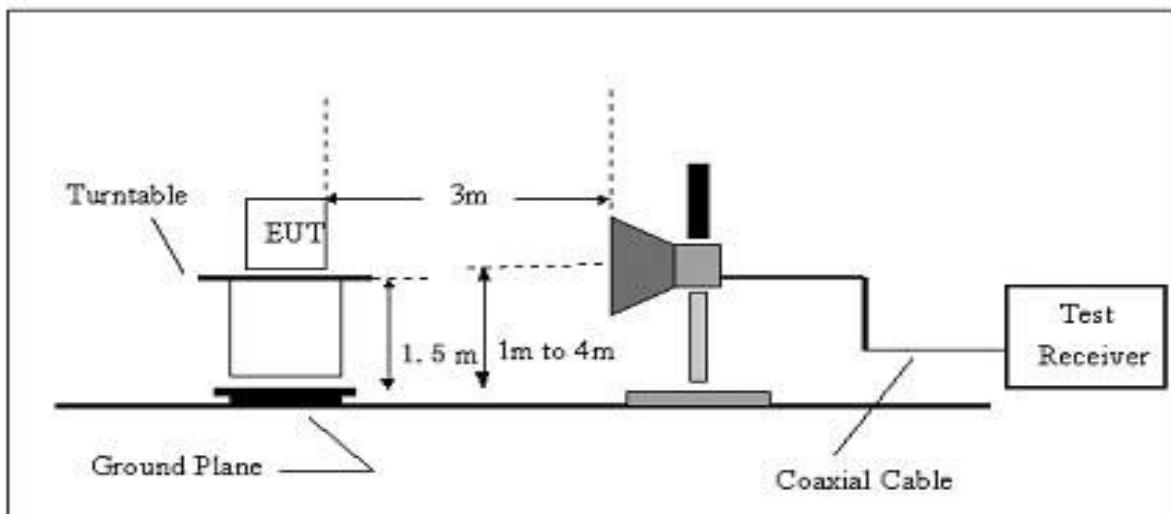
11. TRANSMITTER UNWANTED EMISSIONS IN THE SPURIOUS DOMAIN

11.1 Block Diagram Of Test Setup

(A) Radiated Emission Test Set-Up, Frequency Below 1000MHz



(B) Radiated Emission Test Set-Up Frequency Above 1 GHz





11.2 Limits

Frequency range	Maximum power, e.r.p. (≤ 1 GHz) e.i.r.p. (> 1 GHz)	RBW/VBW
30 MHz to 47 MHz	-36 dBm	100 kHz/300kHz
47 MHz to 74 MHz	-54 dBm	100 kHz/300kHz
74 MHz to 87,5 MHz	-36 dBm	100 kHz/300kHz
87,5 MHz to 118 MHz	-54 dBm	100 kHz/300kHz
118 MHz to 174 MHz	-36 dBm	100 kHz/300kHz
174 MHz to 230 MHz	-54 dBm	100 kHz/300kHz
230 MHz to 470 MHz	-36 dBm	100 kHz/300kHz
470 MHz to 862 MHz	-54 dBm	100 kHz/300kHz
862 MHz to 1 GHz	-36 dBm	100 kHz/300kHz
1 GHz to 12,75 GHz	-30 dBm	1 MHz/3MHz

11.3 Test Procedure

30MHz ~ 1GHz:

- The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber..
- Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.



11.4 Test Results

Frequency (MHz)	Receiver Reading (dB μ V)	Turn table Angle Degree	RX Antenna		Substituted			Absolute Level (dBm)	Result	
			Height (m)	Polar (H/V)	SG Level (dBm)	Cable (dB)	Antenna Gain (dB)		Limit (dBm)	Margin (dB)

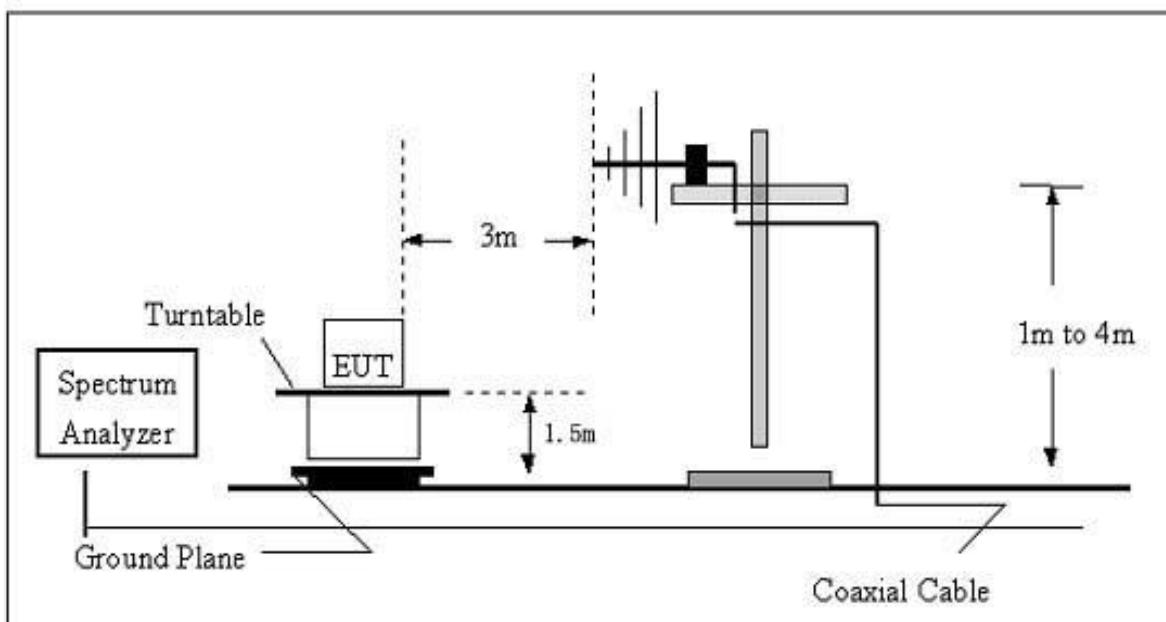
GFSK low channel								
562.17	-54.41	23	1.9	H	-7.4	-61.81	-54	-7.81
562.17	-54.31	273	1.7	V	-7.4	-61.71	-54	-7.71
4804.00	-49.35	195	1.1	H	-0.43	-49.78	-30	-19.78
4804.00	-49.77	68	1.6	V	-0.43	-50.2	-30	-20.2
7206.00	-58.63	78	1.9	H	8.31	-50.32	-30	-20.32
7206.00	-59.27	302	1.7	V	8.31	-50.96	-30	-20.96
GFSK Mid channel								
562.17	-56.84	230	1.7	H	-7.4	-64.24	-54	-10.24
562.17	-58.13	306	1.9	V	-7.4	-65.53	-54	-11.53
4882.00	-48.21	98	1.4	H	-0.37	-48.58	-30	-18.58
4882.00	-48.79	175	1.8	V	-0.37	-49.16	-30	-19.16
7323.00	-57.42	119	1.4	H	8.83	-48.59	-30	-18.59
7323.00	-58.33	168	1.9	V	8.83	-49.5	-30	-19.5
GFSK high channel								
562.17	-56.69	278	2	H	-7.4	-64.09	-54	-10.09
562.17	-57.31	204	2	V	-7.4	-64.71	-54	-10.71
4960.00	-50.48	286	1.7	H	-0.32	-50.8	-30	-20.8
4960.00	-50.22	198	1.3	V	-0.32	-50.54	-30	-20.54
7440.00	-57.54	59	1.8	H	9.35	-48.19	-30	-18.19
7440.00	-58.47	335	1.6	V	9.35	-49.12	-30	-19.12



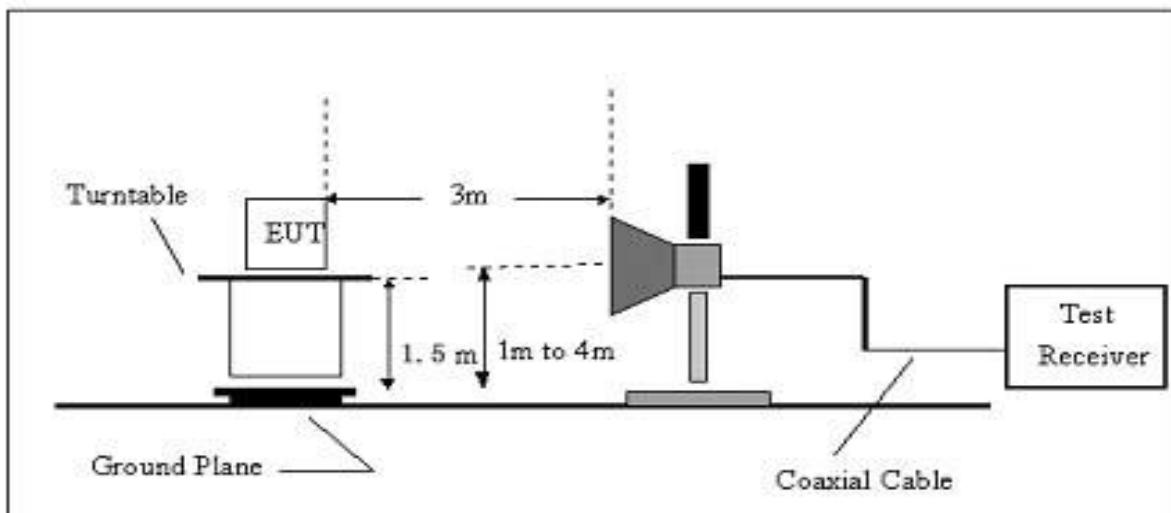
12.RECEIVER SPURIOUS EMISSIONS

12.1 Block Diagram Of Test Setup

(A) Radiated Emission Test Set-Up, Frequency Below 1000MHz



(B) Radiated Emission Test Set-Up Frequency Above 1 GHz



12.2 Limits

Frequency(MHz)	Limit
30-1000	-57dBm
1000-12750	-47dBm



12.3 Test Procedure

30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- a. The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber..
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

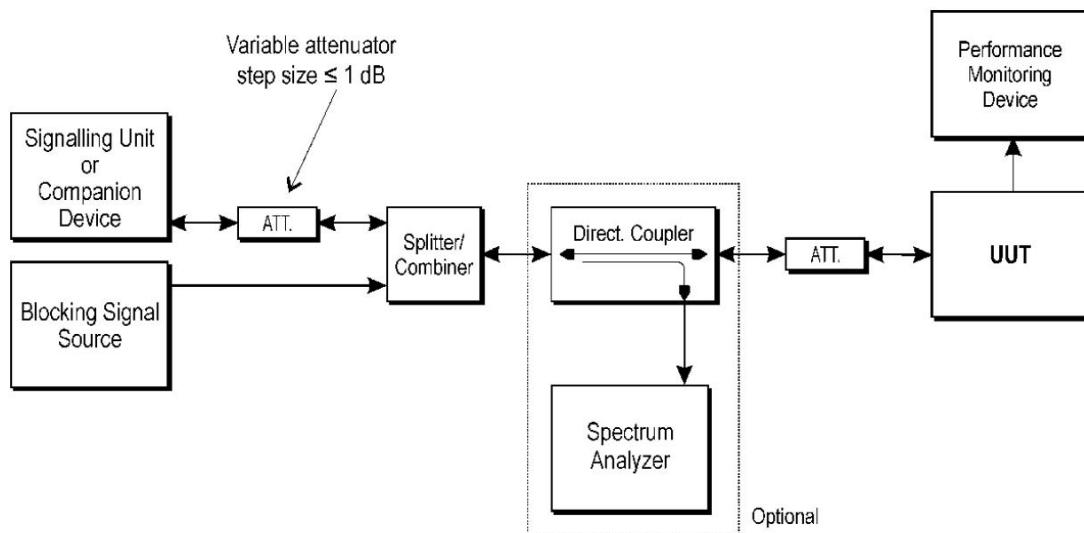


12.4 Test Results

Frequency (MHz)	Receiver Reading (dB μ V)	Turn table Angle Degree	RX Antenna		Substituted			Absolute Level (dBm)	Result	
			Height (m)	Polar (H/V)	SG Level (dBm)	Cable (dB)	Antenna Gain (dB)		Limit (dBm)	Margin (dB)
GFSK low channel										
333.69	-54.31	346	1.5	H	-12.6	-66.91	-57	-9.91		
333.69	-55.66	90	1.1	V	-12.6	-68.26	-57	-11.26		
2489.76	-51.2	309	1.3	H	-6.8	-58	-47	-11		
2489.76	-53.45	264	1.6	V	-6.8	-60.25	-47	-13.25		
GFSK Mid channel										
333.69	-55.63	222	1.6	H	-12.6	-68.23	-57	-11.23		
333.69	-55.28	105	1.7	V	-12.6	-67.88	-57	-10.88		
2489.76	-52.22	203	1.4	H	-6.8	-59.02	-47	-12.02		
2489.76	-52.19	67	1.2	V	-6.8	-58.99	-47	-11.99		
GFSK high channel										
333.69	-55.41	148	1.1	H	-12.6	-68.01	-57	-11.01		
333.69	-54.88	333	1.3	V	-12.6	-67.48	-57	-10.48		
2489.76	-50.62	18	1.6	H	-6.8	-57.42	-47	-10.42		
2489.76	-54.31	80	1.8	V	-6.8	-61.11	-47	-14.11		

13.RECEIVER BLOCKING

13.1 Block Diagram Of Test Setup



13.2 Limit

Wanted signal mean power from companion device (dBm)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 2)	Type of blocking signal
$P_{min} + 6 \text{ dB}$	2 380 2 503,5	-57	CW
$P_{min} + 6 \text{ dB}$	2 300 2 583,5	-47	CW

NOTE 1: P_{min} is the minimum level of the wanted signal (in dBm) required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 2: The levels specified are levels in front of the UUT antenna. In case of conducted measurements, the levels have to be corrected by the actual antenna assembly gain.

13.3 Test procedure

Refer to ETSI EN 300 328 Clause 5.4.11.2.

13.4 Test Result

Pass



14.EUT PHOTOGRAPHS



Photo 1



Photo 2

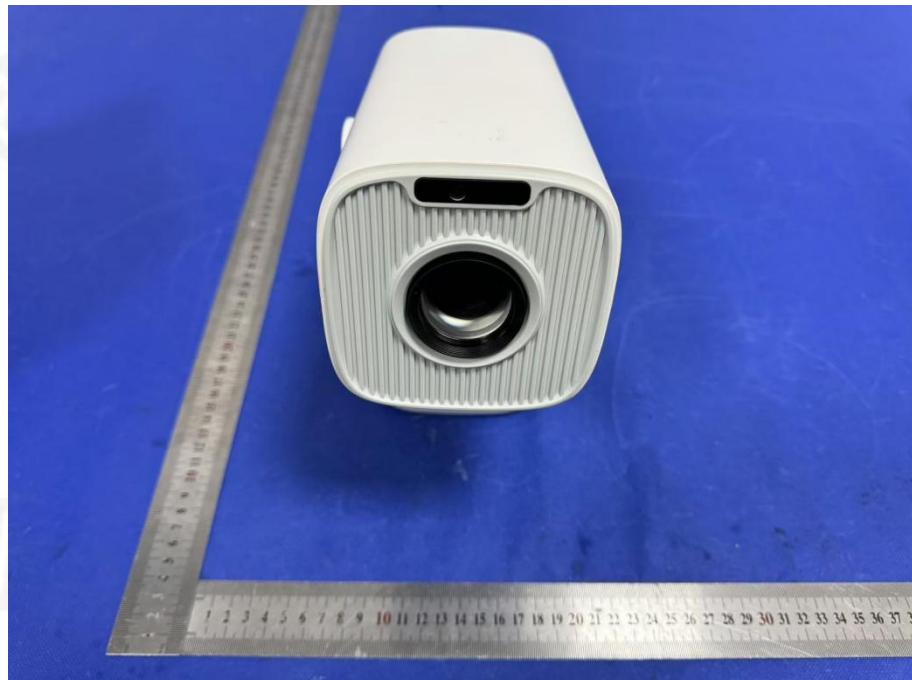


Photo 3

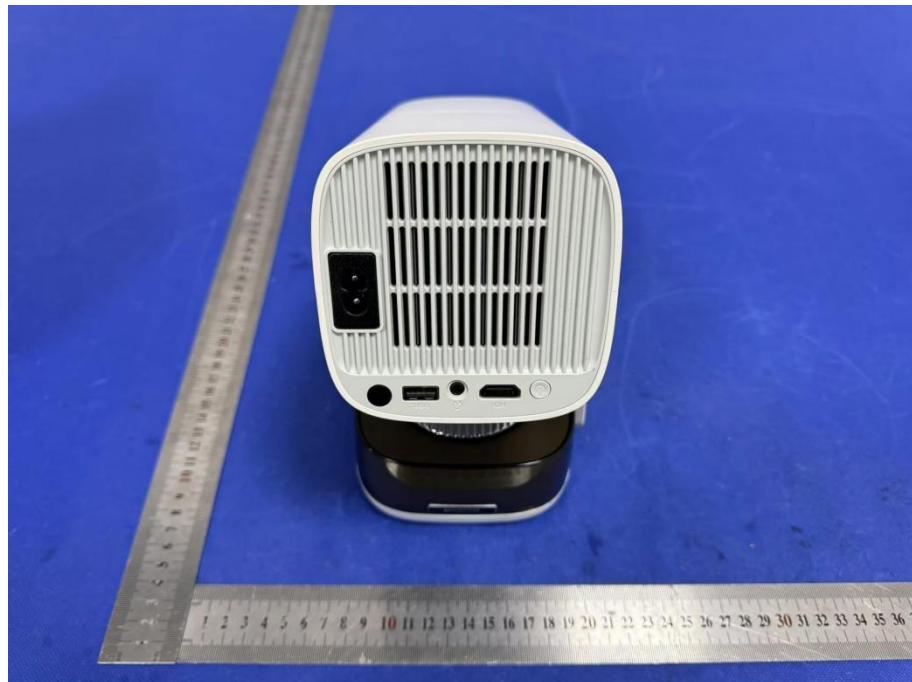


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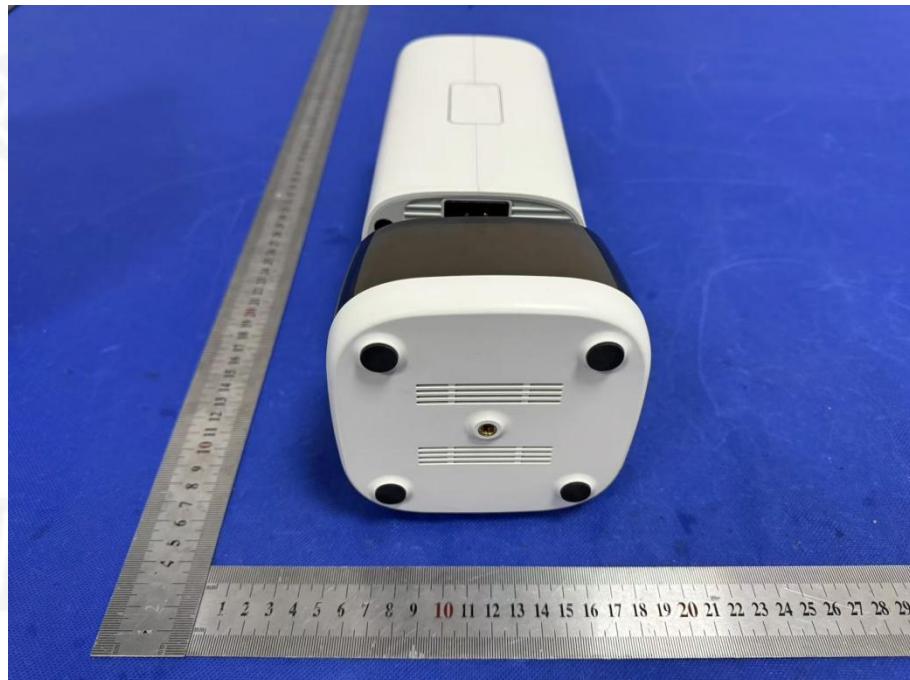


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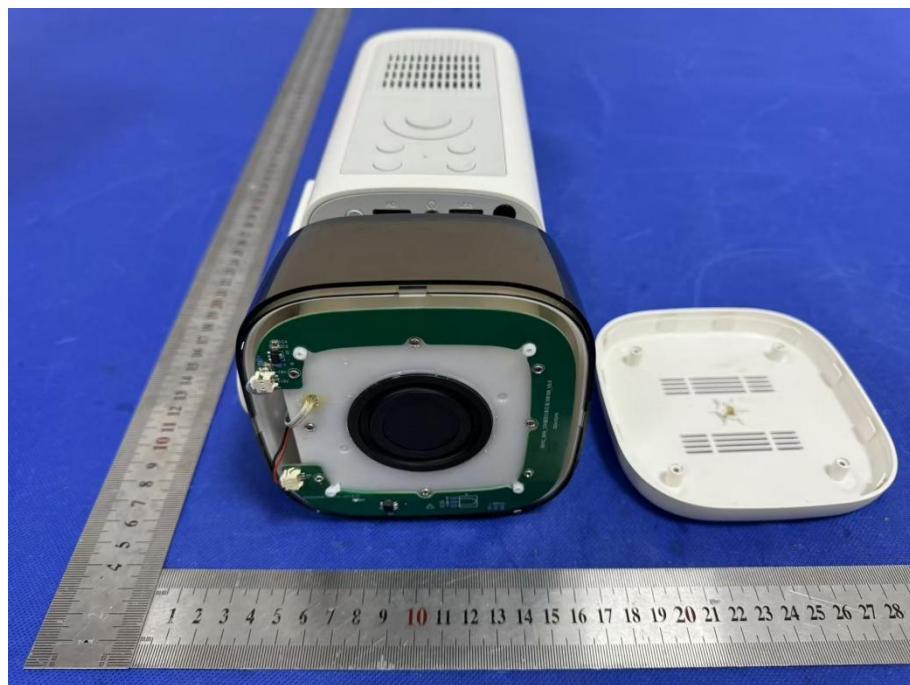


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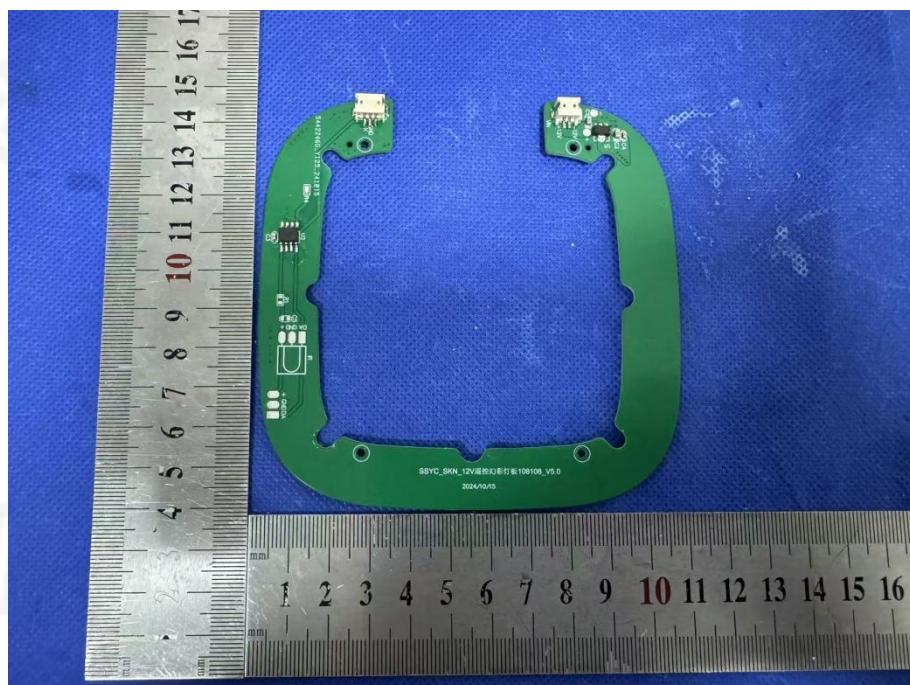


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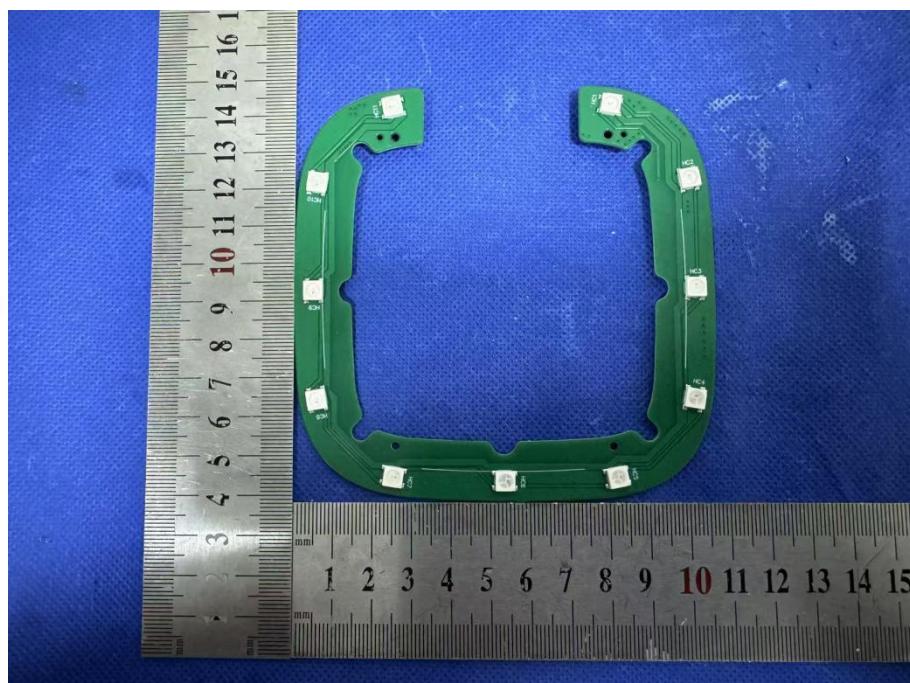


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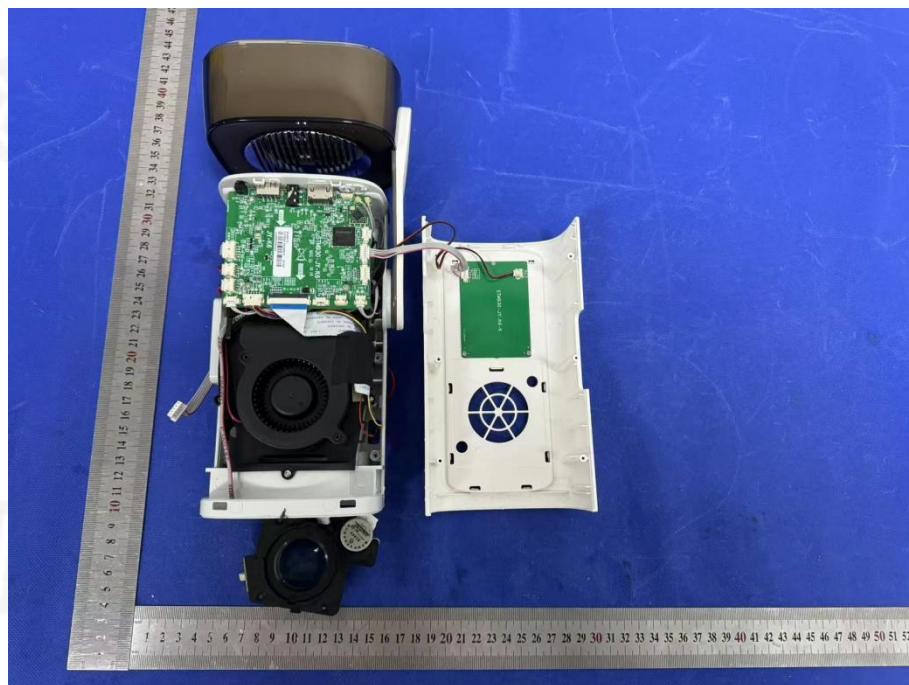


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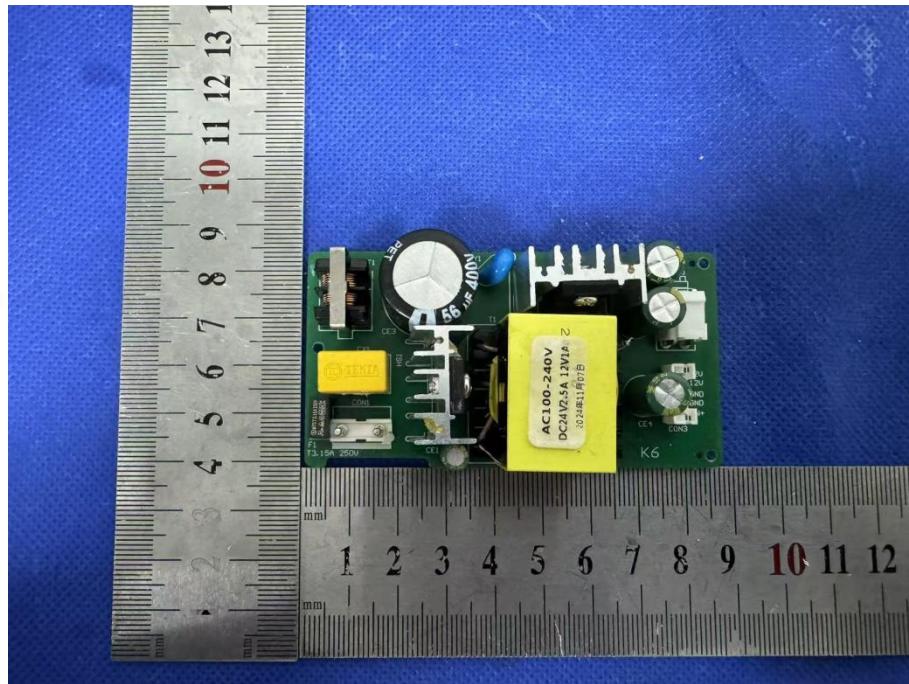


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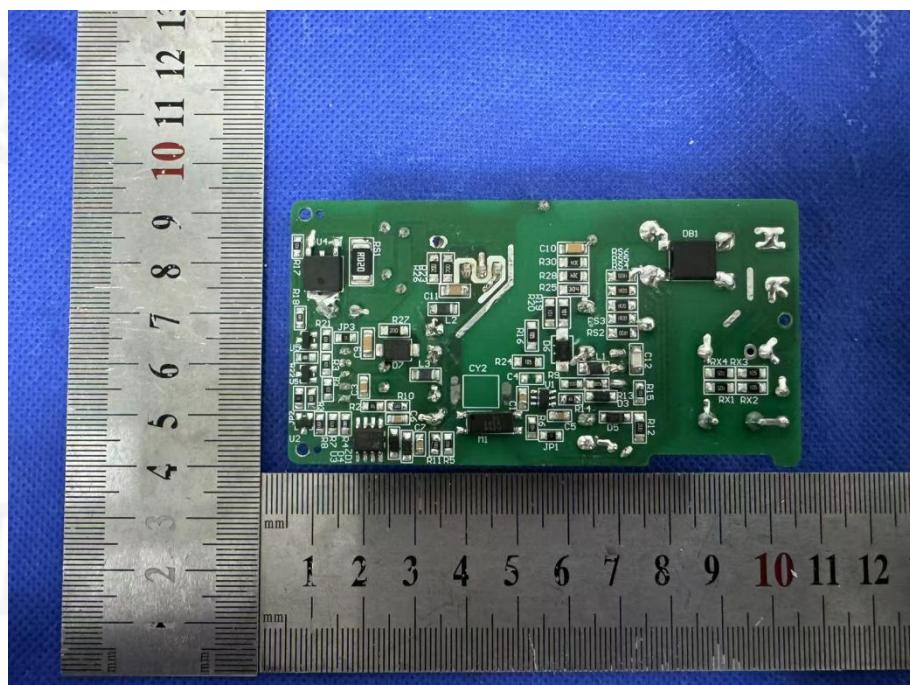


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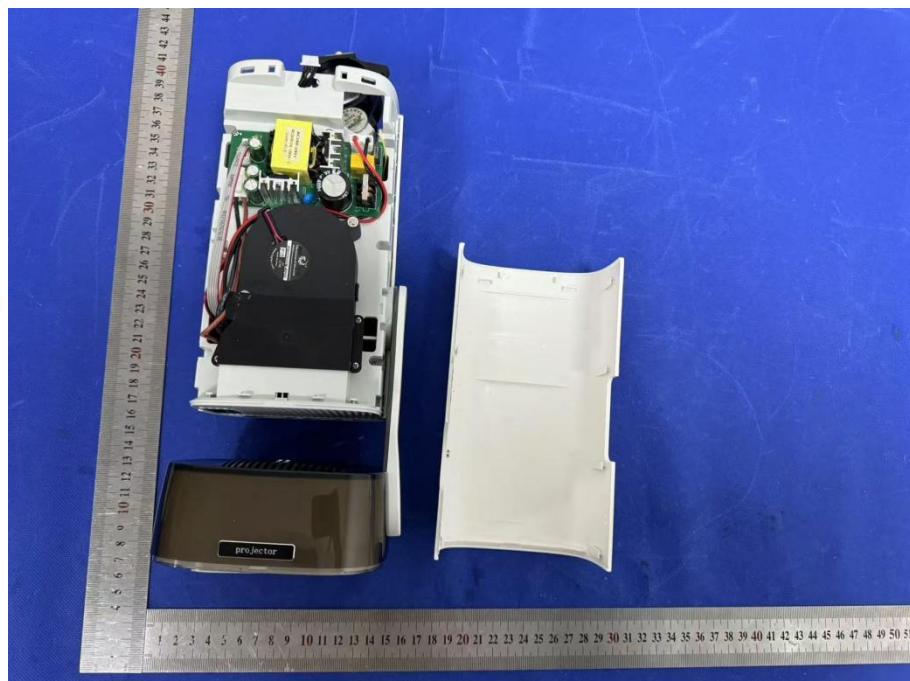


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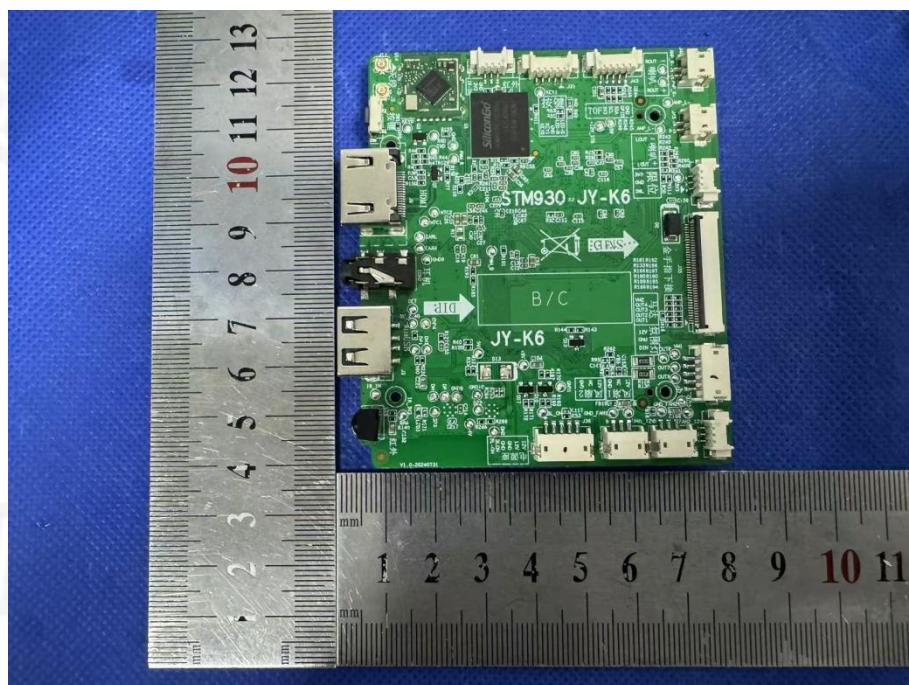


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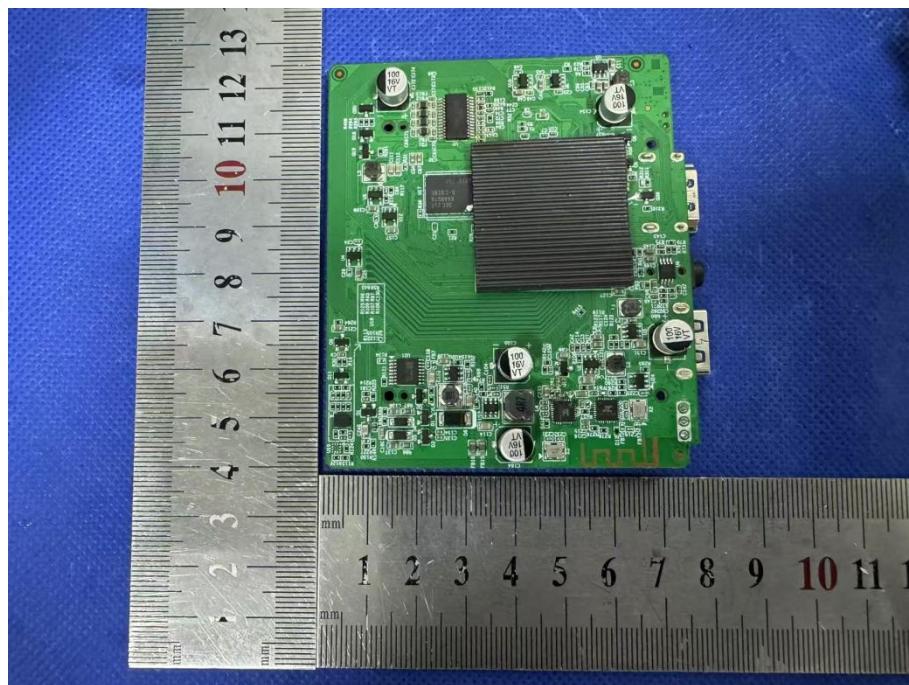


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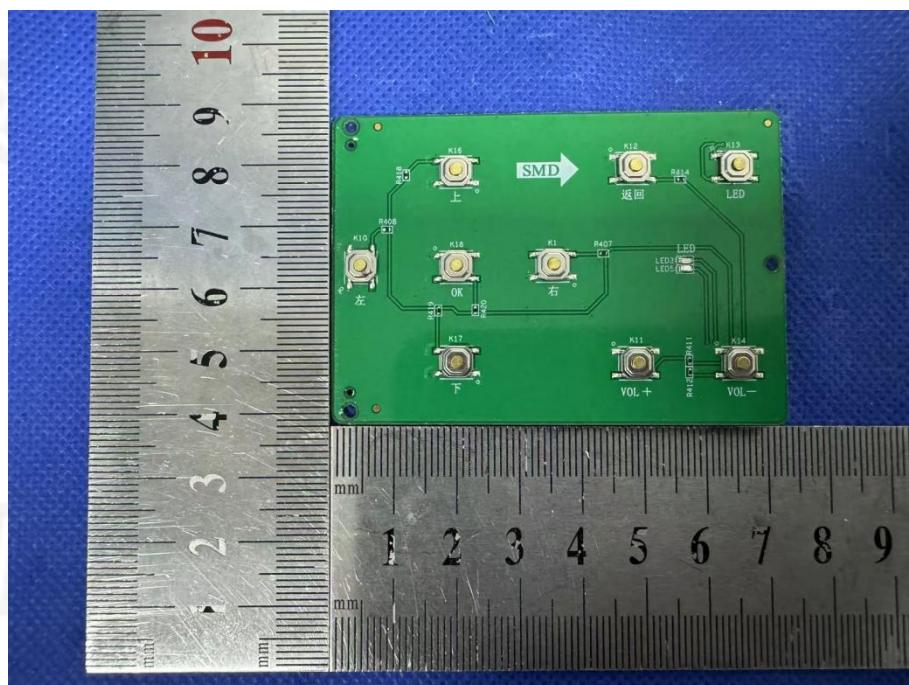


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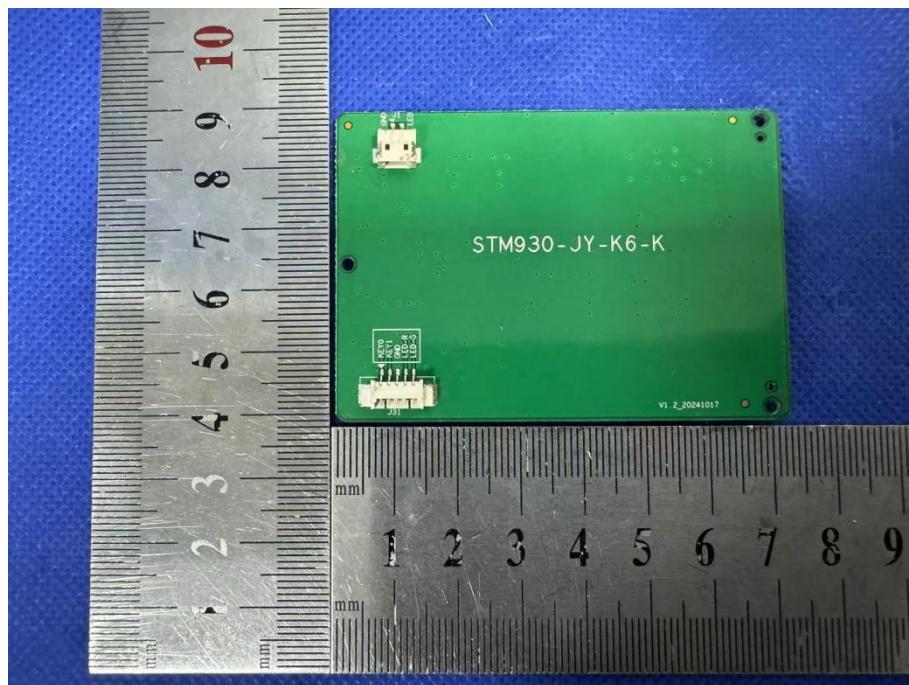


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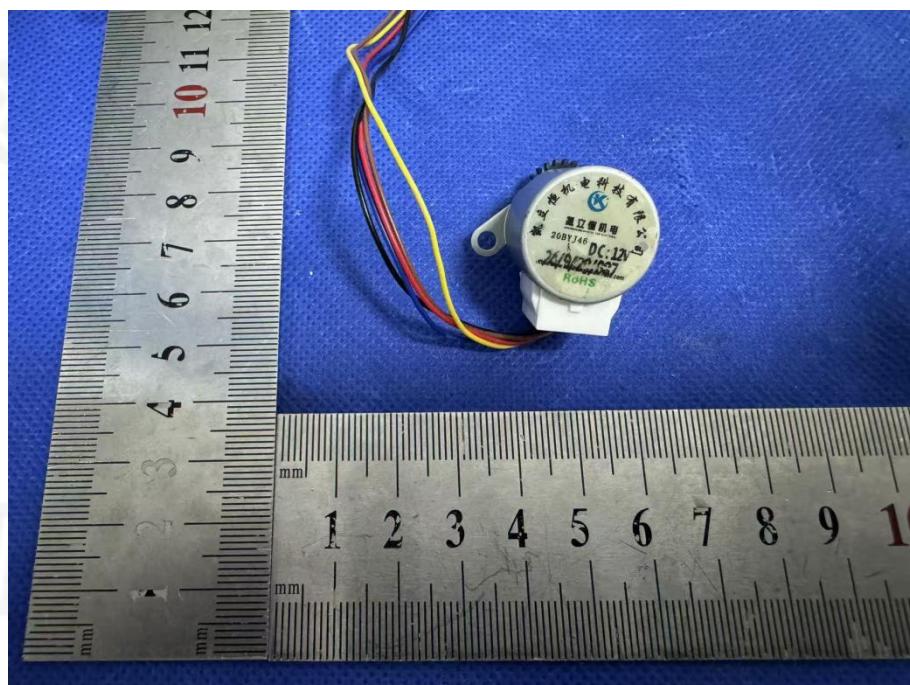


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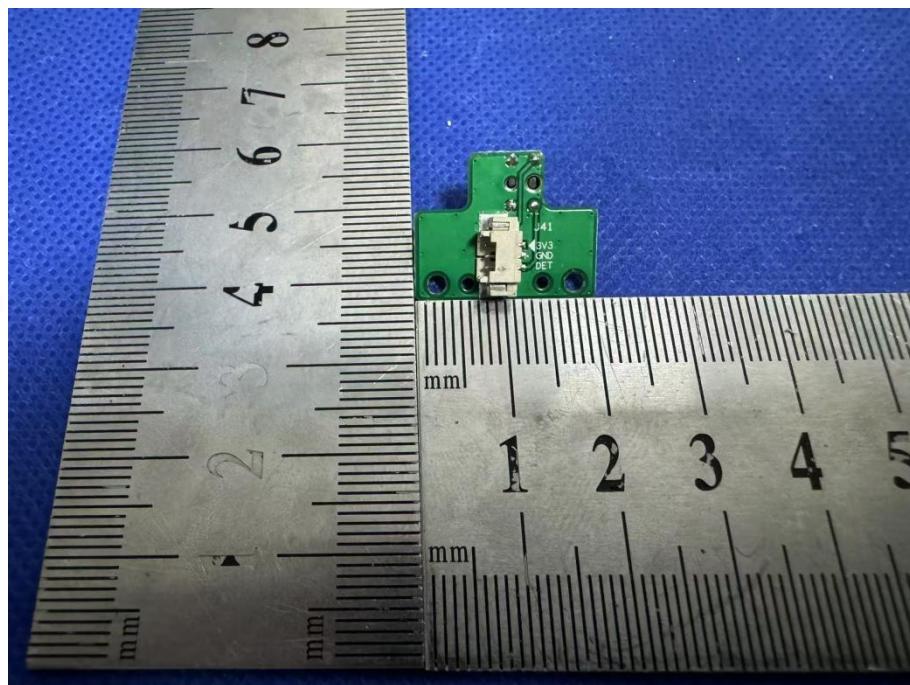


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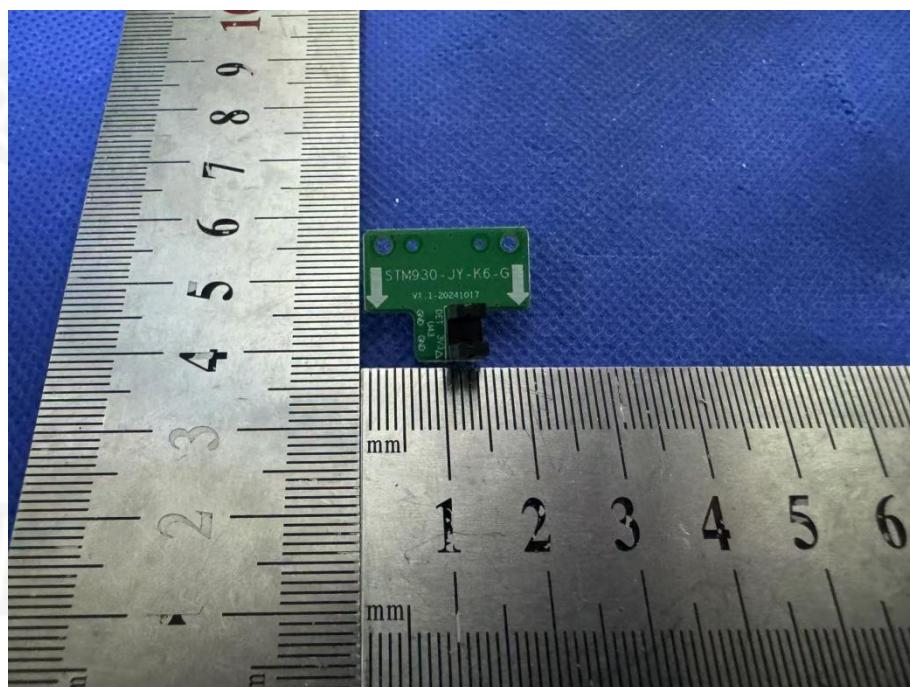


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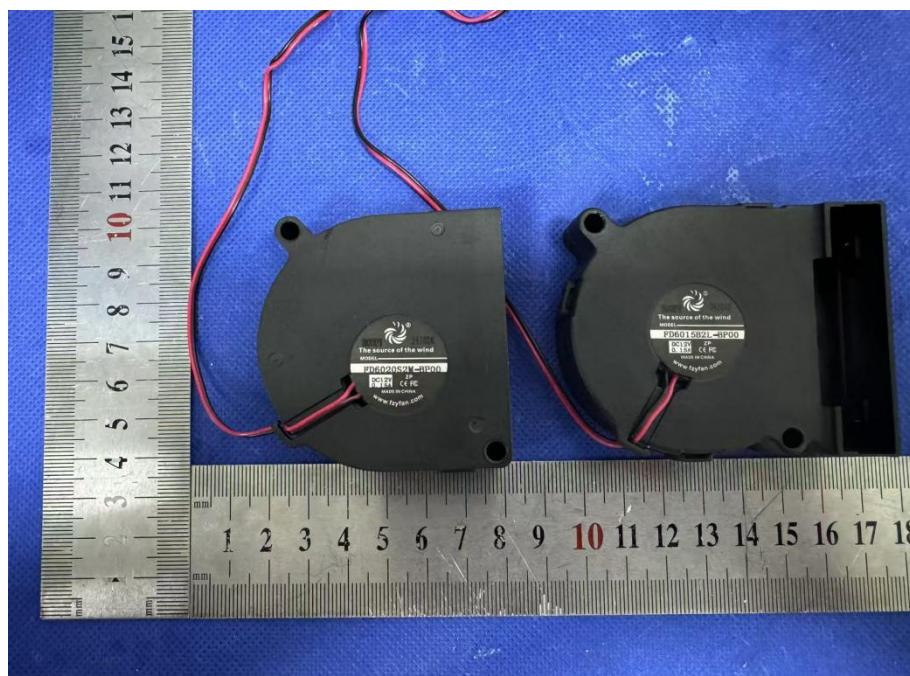


Photo 20

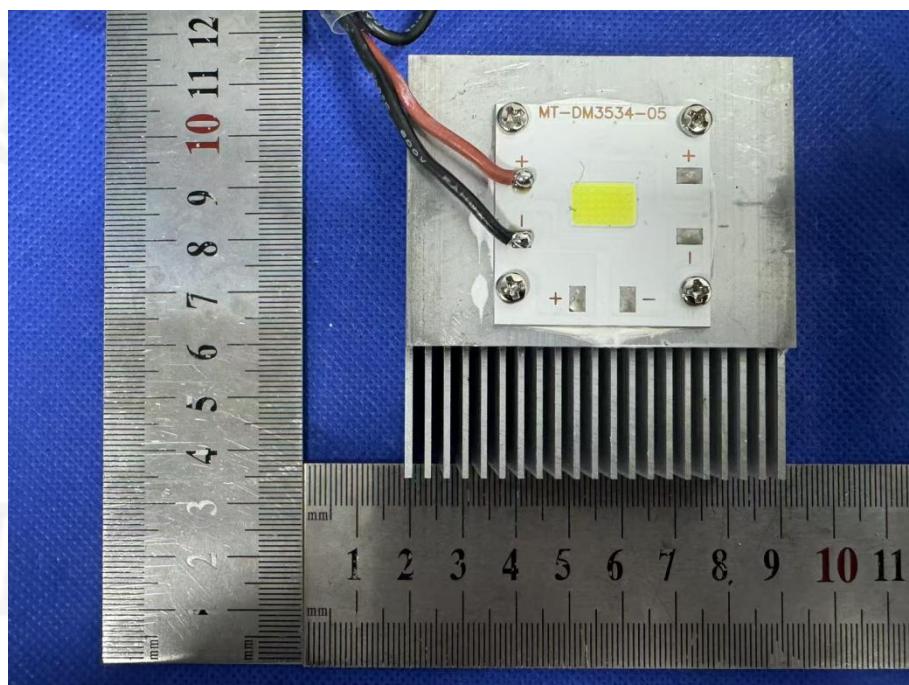


Photo 21



Photo 22



15.EUT TEST SETUP Photographs

Spurious emissions

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***** END OF REPORT *****

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